

**Notice of References Cited**

Application/Control No.

10/737,421

Applicant(s)/Patent Under  
Reexamination  
BURKHARDT ET AL.

Examiner

THANH S. PHAN

Art Unit

2833

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,430,005	02-1984	Nishimura, Kosuke	368/67
*	B	US-6,618,328	09-2003	Ellner et al.	368/88
*	C	US-2004/0237319	12-2004	Stotz, Gerhard	033/356
*	D	US-2003/0210612	11-2003	Stern, Max Meier	368/110
*	E	US-2003/0016315	01-2003	Ueno et al.	349/66
*	F	US-5,210,722	05-1993	Schwartz, Herbert	368/88
*	G	US-4,817,196	03-1989	MacNak et al.	455/193.1
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.